


<b>Search Notes</b> 	<b>Application/Control No.</b> 10616140	<b>Applicant(s)/Patent Under Reexamination</b> TURK ET AL.
	<b>Examiner</b> Eunhee Kim	<b>Art Unit</b> 2123

SEARCHED			
Class	Subclass	Date	Examiner
703	7	5/25/2008	Eunhee Kim

SEARCH NOTES		
Search Notes	Date	Examiner
East Text search (see attached)	5/25/2008	Eunhee Kim

INTERFERENCE SEARCH			
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